

Notice of References Cited	Application/Control No. 10/644,583	Applicant(s)/Patent Under Reexamination GRECH ET AL.	
	Examiner David M. Naff	Art Unit 1651	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,676,836	10-1997	Yamasaki et al.	210/602
*	B	US-6,365,384 B1	04-2002	Iijima, Ryusuke	435/174
*	C	US-6,322,782 B1	11-2001	Walker et al.	424/93.4
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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